## Notice of References Cited Application/Control No. 09/716,845 Examiner M. Lee Applicant(s)/Patent Under Reexamination VANTALON ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
	A	US-4,472,686	09-1984	Nishimura et al.	341/53
	В	US-4,893,306	01-1990	Chao et al.	370/458
	С	US-4,891,805	01-1990	Fallin, David B.	370/229
	D	US-5,212,687	05-1993	De La Bourdonnaye, Philippe	370/538
	E	US-			
	F	US-			·
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*	·	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	now, many positive							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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